Issue Classification	

Application/Control No. 10/801,840	Applicant(s)/Patent under Reexamination FUJITA, ATSUSHI
Examiner	Art Unit
Devona E. Faulk	2615

_				ISSUE	CL	.AS	SIF	ICAT	ION					
		ORIGINAL				INTERNATIONAL CLASSIFICATION								
CLASS SUBCLASS							С	LAIMED			NON-CLAIMED			
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Devona E. Faulk 10/12/2006 (Assistant Examiner) (Date)						N CHIR		VINER	Total Claims Allowed: 7					
(Legal Instruments Examiner) (Date (Primary E							FR 20	600 (Date)		O.G. Print Fig.				

	Claims renumbered in the same order as presented by applicant									☐ CPA			☐ T.D.			☐ R.1.47			
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
7	1			31			61			91			121			151	l		181
2	2			32			62			92			122			152			182
3	3			33			63			93			123			153			183
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5	6			36			66			96			126			156			186
12	7			37			67			97			127			157			187
7	8]	*	38			68			98			128			158			188
	9			39			69			99			129			159			189
	10]		40			70			100			130			160			190
	11			41			71			101			131			161			191
	12	1		42			72			102			132			162			192
	13]		43			73			103			133			163			193
	14	1		44			74]		104			134			164			194
	15]		45			75			105			135			165			195
	16			46]		76			106			136			166			196
	17	1		47]		77			107			137			167			197
	18			48			78			108			138			168			198
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	20			50			80]		110			140]		170			200
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	23]		53]		83			113			143			173			203
	24]	[54			84			114			144			174			204
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	26]		56			86			116	}		146]		176			206
	27]		57			87			117			147]		177			207
	28			58			88			118			148]		178			208
	29			59			89			119			149		i	179			209
	30			60			90			120			150			180			210